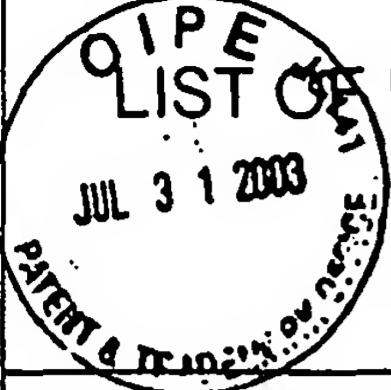


LIST OF PRIOR ART CITED BY APPLICANT (PTO-1449)				ATTY. DOCKET NO. P-0483	APPLN. SERIAL NO. 10/624,524	
				APPLICANT(S) Yong-Hee LEE and Joon JANG		
				FILING DATE July 23, 2003	GROUP 2612	
U.S. PATENT DOCUMENTS						
EXAMINER'S INITIALS	*PATENT NO.	*ISSUE DATE	*INVENTOR NAME	CLASS	SUBCLASS	FILING DATE
TRADE MARK OFFICE						
U.S. PATENT APPLICATION PUBLICATIONS						
	*PATENT APPLN. PUB. NO.	*PUB. DATE	*APPLICANT	CLASS	SUBCLASS	
TRADE MARK OFFICE						
U.S. PATENT APPLICATIONS						
	APPLN. NO.	*FILING DATE	*INVENTOR	CLASS	SUBCLASS	
TRADE MARK OFFICE						
FOREIGN PATENT DOCUMENTS						
EXAMINER'S INITIALS	PATENT NO.	DATE	COUNTRY	CLASS	SUBCLASS	Translation Yes No
NT	10-2004-0006710	1/24/04	KOREA	—	—	Part. Abst
OTHER ART (Including Author, Title, Date, Pertinent Pages, Publisher, Place of Publication, Etc.)						
NT	Korean Office Action dated July 28, 2004					

EXAMINER: Initial if reference considered, whether or not citation is in conformance with MPEP 609; draw line through citation if not in conformance and not considered. Include copy of this form with next communication to Applicant. DYK/RAV:knv

EXAMINER: Initial if reference considered, whether or not citation is in conformance with MPEP 609; draw line through citation if not in conformance and not considered. Include copy of this form with next communication to Applicant.

 <p>Q1 P E LIST OF PRIOR ART CITED BY APPLICANT JUL 31 2003 (PTO-1449)</p>			ATTY. DOCKET NO. P-0 83		APPLN. SERIAL NO. NEW			
			APPLICANT(S) Yong-Hee LEE and J n JAN		FILING DATE 7/23/2003		GROUP Unknown	
			U.S. PATENT DOCUMENTS					
			EXAMINER'S INITIALS	*PATENT NO.	*ISSUE DATE	*INVENTOR NAME		CLASS
U.S. PATENT DOCUMENTS								
U.S. PATENT APPLICATION PUBLICATIONS								
	*PATENT APPN. PUB. NO.	*PUB. DATE	*APPLICANT		CLASS	SUBCLASS		
U.S. PATENT APPLICATIONS								
	*APPLN. NO.	*FILING DATE	*INVENTOR		CLASS	SUBCLASS		
FOREIGN PATENT DOCUMENTS								
EXAMINER'S INITIALS	PATENT NO.	DATE	COUNTRY	CLASS	SUBCLASS	Translation		
						Yes	No	
NT	2001-0047067	6/15/2003	KOREA			Abstract Only		
NT	2002-0014156	2/25/2002	KOREA			Abstract Only		
NT	2002-0038182	5/23/2002	KOREA			Abstract Only		
OTHER ART (Including Author, Title, Date, Pertinent Pages, Publisher, Place of Publication, Etc.)								
EXAMINER <i>/Nhan Tran/</i>			DATE CONSIDERED <i>11/03/2006</i>					

EXAMINER: Initial if reference considered, whether or not citation is in conformance with MPEP 609; draw line through citation if not in conformance and not considered. Include copy of this form with next communication to Applicant.

<p align="center">LIST OF PRIOR ART CITED BY APPLICANT (PTO-1449)</p>			ATTY. DOCKET NO. P-0483		APPLN. SERIAL NO. NEW	
			APPLICANT(S) Yong-Hee LEE and Joon JANG			
			FILING DATE 7/23/2003		GROUP unknown	
U.S. PATENT DOCUMENTS						
EXAMINER'S INITIALS	*PATENT NO.	*ISSUE DATE	*INVENTOR NAME		CLASS	SUBCLASS
U.S. PATENT APPLICATION PUBLICATIONS						
	*PATENT APPLN. PUB. NO.	*PUB. DATE	*APPLICANT		CLASS	SUBCLASS
U.S. PATENT APPLICATIONS						
	*APPLN. NO.	*FILING DATE	*INVENTOR		CLASS	SUBCLASS
FOREIGN PATENT DOCUMENTS						
EXAMINER'S INITIALS	PATENT NO.	DATE	COUNTRY	CLASS	SUBCLASS	Translation
						Yes
NT	2001-0047067	6/15/2003	KOREA			X
NT	2001-1320463	11/16/2001	JAPAN			PART. ABST.
NT	2002-2141977	5/17/2002	JAPAN			PART. ABST.
NT	2002-0014156	2/25/2002	KOREA			X
NT	2002-0038182	5/23/2002	KOREA			X
OTHER ART (Including Author, Title, Date, Pertinent Pages, Publisher, Place of Publication, Etc.)						
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